Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
09/826,067	FISCHER ET AL.	
Examiner	Art Unit	
Afsar M. Oureshi	2667	

SEARCHED			
Class	Subclass	Date	Examiner
370	473	5/8/2005	AQ
	503		
	509		
	510		
	516	,	
370	356	5/9/2005	AQ
,	395.5		
	395.62		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	516	5/9/2005	AQ
	395.62		
375	356		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EASTWEST	5/9/2005	AQ
ACM\IEEE		
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